BAS21AVD
High-voltage switching diodes
1 August 2013
Product data sheet

## 1. General description

Triple high-voltage switching diodes, encapsulated in a SOT457 (SC-74/TSOP6) small Surface-Mounted Device (SMD) plastic package.

## 2. Features and benefits

- High switching speed: $\mathrm{t}_{\mathrm{rr}} \leq 50 \mathrm{~ns}$
- Reverse voltage: $\mathrm{V}_{\mathrm{R}} \leq 200 \mathrm{~V}$
- Repetitive peak reverse voltage: $\mathrm{V}_{\mathrm{RRM}} \leq 250 \mathrm{~V}$
- Small SMD plastic package
- Low capacitance: $\mathrm{C}_{\mathrm{d}} \leq 5 \mathrm{pF}$
- AEC-Q101 qualified
- Repetitive peak forward current: $I_{\text {FRM }} \leq 1 \mathrm{~A}$


## 3. Applications

- High-voltage switching in surface-mounted circuits
- Automotive
- Communication


## 4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions |  | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Per diode |  |  |  |  |  |  |  |
| $\mathrm{I}_{\mathrm{F}}$ | forward current | pulsed; $\mathrm{t}_{\mathrm{p}} \leq 300 \mu \mathrm{~s} ; \delta \leq 0.02$ | [1] | - | - | 200 | mA |
| $V_{R}$ | reverse voltage |  |  | - | - | 200 | V |
| Per diode |  |  |  |  |  |  |  |
| $\mathrm{I}_{\mathrm{R}}$ | reverse current | $\begin{aligned} & \mathrm{V}_{\mathrm{R}}=200 \mathrm{~V} ; \mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C} ; \text { pulsed; } \\ & \mathrm{t}_{\mathrm{p}} \leq 300 \mu \mathrm{~s} ; \delta \leq 0.02 \end{aligned}$ |  | - | 25 | 100 | nA |
| $\mathrm{t}_{\mathrm{rr}}$ | reverse recovery time | $\begin{aligned} & I_{F}=30 \mathrm{~mA} ; I_{R}=30 \mathrm{~mA} ; I_{R(\text { meas })}=3 \mathrm{~mA} ; \\ & R_{L}=100 \Omega ; T_{a m b}=25^{\circ} \mathrm{C} \end{aligned}$ |  | - | 16 | 50 | ns |

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

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## 5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
| :---: | :---: | :---: | :---: | :---: |
| 1 | A1 | anode (diode 1) | -6 - $\square^{4}$ | 6 5 4 |
| 2 | A2 | anode (diode 2) |  |  |
| 3 | A3 | anode (diode 3) | $\stackrel{\circ}{\square}-\overline{1}-\overline{2}$ | $\text { 市 } \overline{4} \quad \frac{1}{4}$ |
| 4 | K3 | cathode (diode 3) | TSOP6 (SOT457) | $\bigcirc$ |
| 5 | K2 | cathode (diode 2) |  | 1 2 3 |
| 6 | K1 | cathode (diode 1) |  | 0 |

## 6. Ordering information

Table 3. Ordering information

| Type number | Package |  |  |  |
| :--- | :--- | :--- | :--- | :--- |
|  | Name | Description | Version |  |
| BAS21AVD | TSOP6 | plastic surface-mounted package (TSOP6); 6 leads | SOT457 |  |

## 7. Marking

Table 4. Marking codes

| Type number | Marking code |
| :--- | :--- |
| BAS21AVD | E6 |

## 8. Limiting values

Table 5. Limiting values
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions |  | Min | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Per diode |  |  |  |  |  |  |
| $V_{\text {RRM }}$ | repetitive peak reverse voltage |  |  | - | 250 | V |
| $V_{R}$ | reverse voltage |  |  | - | 200 | V |
| $\mathrm{I}_{\mathrm{F}}$ | forward current | pulsed; $\mathrm{t}_{\mathrm{p}} \leq 300 \mu \mathrm{~s} ; \delta \leq 0.02$ | [1] | - | 200 | mA |
| IFRM | repetitive peak forward current | $\mathrm{t}_{\mathrm{p}} \leq 1 \mathrm{~ms} ; \delta \leq 25 \%$ |  | - | 1 | A |
| $\mathrm{I}_{\text {FSM }}$ | non-repetitive peak forward | $\mathrm{t}_{\mathrm{p}}=10 \mu \mathrm{~s} ; \mathrm{T}_{\mathrm{j} \text { (init) }}=25^{\circ} \mathrm{C}$; square wave |  | - | 16 | A |
|  |  | $\mathrm{t}_{\mathrm{p}}=100 \mu \mathrm{~s} ; \mathrm{T}_{\mathrm{j}(\text { (init })}=25^{\circ} \mathrm{C}$; square wave |  | - | 8 | A |
|  |  | $\mathrm{t}_{\mathrm{p}}=10 \mathrm{~ms} ; \mathrm{T}_{\mathrm{j} \text { (nit) }}=25^{\circ} \mathrm{C}$; square wave |  | - | 2 | A |


| Symbol | Parameter | Conditions |  | Min | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Per device; one diode loaded |  |  |  |  |  |  |
| $P_{\text {tot }}$ | total power dissipation | $\mathrm{T}_{\text {amb }} \leq 25^{\circ} \mathrm{C}$ | [1] | - | 250 | mW |
|  |  |  | [2] | - | 295 | mW |
| $\mathrm{T}_{\text {stg }}$ | storage temperature |  |  | -65 | 150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{j}}$ | junction temperature |  |  | - | 150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {amb }}$ | ambient temperature |  |  | -65 | 150 | ${ }^{\circ} \mathrm{C}$ |

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.
[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for cathode $1 \mathrm{~cm}^{2}$.

## 9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions |  | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Per device; one diode loaded |  |  |  |  |  |  |  |
| $\mathrm{R}_{\text {th( }(-a)}$ | thermal resistance from junction to ambient | in free air | [1] | - | - | 500 | K/W |
|  |  |  | [2] | - | - | 425 | K/W |
| $\mathrm{R}_{\text {th(j-sp) }}$ | thermal resistance from junction to solder point |  | [3] | - | - | 140 | K/W |

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for cathode $1 \mathrm{~cm}^{2}$.
[3] Soldering point of cathode tab.

## 10. Characteristics

Table 7. Characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Per diode |  |  |  |  |  |  |
| $V_{F}$ | forward voltage | $\mathrm{I}_{\mathrm{F}}=100 \mathrm{~mA} ; \mathrm{T}_{\text {amb }}=25^{\circ} \mathrm{C}$ | - | - | 1 | V |
|  |  | $\mathrm{I}_{\mathrm{F}}=200 \mathrm{~mA} ; \mathrm{T}_{\text {amb }}=25^{\circ} \mathrm{C}$ | - | - | 1.25 | V |
| $\mathrm{I}_{\mathrm{R}}$ | reverse current | $\begin{aligned} & \mathrm{V}_{\mathrm{R}}=200 \mathrm{~V} ; \text { pulsed; } \mathrm{t}_{\mathrm{p}} \leq 300 \mu \mathrm{~s} ; \\ & \delta \leq 0.02 ; \mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C} \end{aligned}$ | - | 25 | 100 | nA |
|  |  | $V_{R}=200 \mathrm{~V} ; \mathrm{T}_{\mathrm{j}}=150^{\circ} \mathrm{C}$ | - | - | 100 | $\mu \mathrm{A}$ |
| $\mathrm{C}_{\text {d }}$ | diode capacitance | $\mathrm{f}=1 \mathrm{MHz} ; \mathrm{V}_{\mathrm{R}}=0 \mathrm{~V} ; \mathrm{T}_{\text {amb }}=25^{\circ} \mathrm{C}$ | - | 0.6 | 5 | pF |
| $\mathrm{t}_{\mathrm{rr}}$ | reverse recovery time | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=30 \mathrm{~mA} ; \mathrm{I}_{\mathrm{R}}=30 \mathrm{~mA} ; \mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C} ; \\ & \mathrm{R}_{\mathrm{L}}=100 \Omega ; \mathrm{I}_{\mathrm{R}(\text { meas })}=3 \mathrm{~mA} \end{aligned}$ | - | 16 | 50 | ns |


(1) $T_{j}=150^{\circ} \mathrm{C}$; typical values
(2) $\mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C}$; typical values
(3) $\mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C}$; maximum values

Fig. 1. Forward current as a function of forward voltage

(1) $V_{R}=V_{R m a x}$; maximum values
(2) $V_{R}=V_{R \max }$; typical values

Fig. 3. Reverse current as a function of junction temperature


Based on square wave currents.
$\mathrm{T}_{\mathrm{j} \text { (init) }}=25^{\circ} \mathrm{C}$
Fig. 2. Non-repetitive peak forward current as a function of pulse duration; maximum values

$\mathrm{f}=1 \mathrm{MHz} ; \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C}$
Fig. 4. Diode capacitance as a function of reverse voltage; typical values


FR4 PCB, standard footprint
Fig. 5. Reverse voltage as a function of ambient temperature; derating curve


FR4 PCB, standard footprint
Fig. 6. Forward current as a function of ambient temperature; derating curve

## 11. Test information


(1) $I_{R}=3 \mathrm{~mA}$

Fig. 7. Reverse recovery time test circuit and waveforms

### 11.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - Stress test qualification for discrete semiconductors, and is suitable for use in automotive applications.

## 12. Package outline



Dimensions in mm


| $\rightarrow$ © | $04-11-08$ |
| :--- | :--- |

Fig. 8. Package outline TSOP6 (SOT457)

## 13. Soldering



QZIZD solder lands
--— solder resist
solder paste
$\stackrel{-}{---1}$ occupied area
Dimensions in mm
sot457_fr
Fig. 9. Reflow soldering footprint for TSOP6 (SOT457)


Q1717 solder lands
－－－－solder resist

1ーーー1 occupied area

Dimensions in mm
preferred transport direction during soldering
sot457＿fw
Fig．10．Wave soldering footprint for TSOP6（SOT457）

## 14. Revision history

Table 8. Revision history

| Data sheet ID | Release date | Data sheet status | Change notice | Supersedes |
| :---: | :---: | :---: | :---: | :---: |
| BAS21AVD v. 2 | 20130801 | Product data sheet | - | BAS21AVD v. 1 |
| Modifications: | - Table 7. Characteristics: parameter unit of $\mathrm{V}_{\mathrm{F}}$ corrected <br> - Packing information: removed <br> - Legal information: updated |  |  |  |
| BAS21AVD v. 1 | 20110110 | Product data sheet | - | - |

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| Document <br> status [1][2] | Product <br> status [3] | Definition |
| :--- | :--- | :--- |
| Objective <br> [short] data <br> sheet | Development | This document contains data from <br> the objective specification for product <br> development. |
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